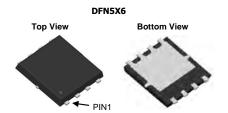


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N-Channel 100 V (D-S) MOSFET

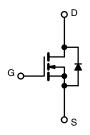
PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, d}	Q _g (Typ.)		
100	0.0065 at V _{GS} = 10 V	110	128nC		

FEATURES • TrenchFET IIPower MOSFET COMPLIANT • 100 % Rgand UIS Tested



APPLICATIONS

- Synchronous rectification
- Primary side switch
- DC/DC converters
- OR-ing
- Power supplies
- Motor drive control
- Battery and load switch



N-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V_{DS}	100	V
Gate-source voltage		V_{GS}	± 20	V
	T _C = 25 °C		110 ^a	
Continuous dusin suggest (T 150 °C)	T _C = 70 °C	1 .	89.8	
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	41.2 b, c	
	T _A = 70 °C	1	27.4 ^{b, c}	^
Pulsed drain current (t = 100 μs)		I _{DM}	440	A
Continuous source-drain diode current	T _C = 25 °C		110 a	
	T _A = 25 °C		6.6 b, c	
Single pulse avalanche current Single pulse avalanche energy L = 0.1 mH		I _{AS}	68	
		E _{AS}	113	mJ
Maximum power dissipation	T _C = 25 °C		175	
	T _C = 70 °C		110	14/
	T _A = 25 °C	P _D	7.25 ^{b, c}	- W
	T _A = 70 °C		5 b, c	
Operating junction and storage temperature range		T _J , T _{stq}	-55 to +150	°C
Soldering recommendations (peak temperature) c			260	- °C

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL TYPICAL		MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R_{thJA}	12	20			
Maximum junction-to-case (drain)	Steady state	R_{thJC}	0.7	1	°C/W		
Maximum junction-to-case (source)	Steady state	R _{th.IC}	1.0	1.4			

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
- d. Calculated based on maximum junction temperature.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•	•		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	-	56	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-6	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μА	
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 \text{ °C}$	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	110	-	-	Α	
Drain-source on-state resistance a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.0065	0.0080	Ω	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	ı	68	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		=.	6285	=.	pF	
Output capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	=.	1819	-		
Reverse transfer capacitance	C _{rss}		-	206	-		
Total gate charge	Qg		-	128	-	nC	
Gate-source charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	-	10	-		
Gate-drain charge	Q _{gd}		-	10.6	-		
Output charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	-	69	104		
Gate resistance	R_g	f = 1 MHz	0.3	1	2	Ω	
Turn-on delay time	t _{d(on)}		-	13	26	ns	
Rise time	t _r	$V_{DD} = 50 \text{ V}, R_L = 2.5 \Omega, I_D \cong 20 \text{ A},$	-	14	28		
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	35	70		
Fall time	t _f		-	9	18		
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	110	^	
Pulse diode forward current (t _p = 100 μs)	I _{SM}	-		-	440	Α	
Body diode voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.7	1.2	V	
Body diode reverse recovery time	t _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		54	100	ns	
Body diode reverse recovery charge	Q _{rr}			76	140	nC	
Reverse recovery fall time	ta			27	-		
Reverse recovery rise time	t _b		_	27	-	ns	

Notes

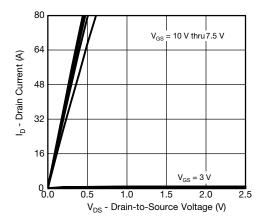
a.P ulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

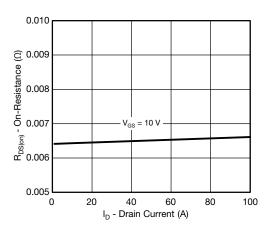
b. Guaranteed by design, not subject to production testing



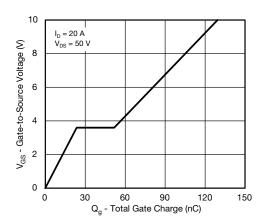
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



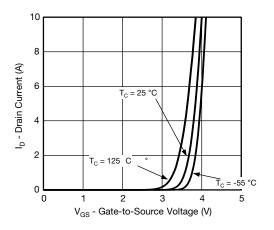
Output Characteristics



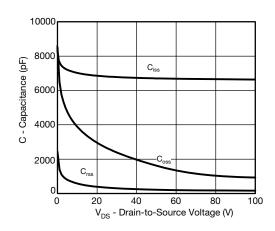
On-Resistance vs. Drain Current and Gate Voltage



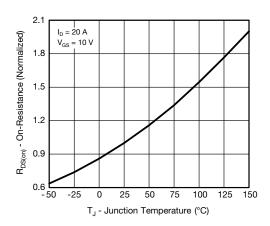
Gate Charge



Transfer Characteristics



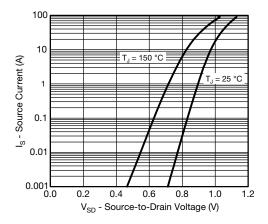
Capacitance



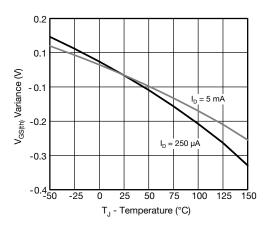
On-Resistance vs. Junction Temperature



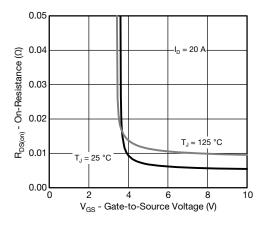
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



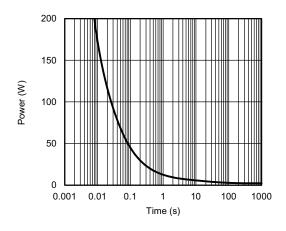
Source-Drain Diode Forward Voltage



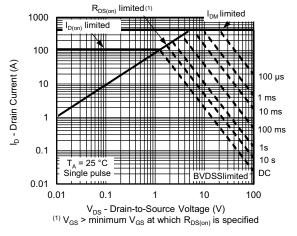
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



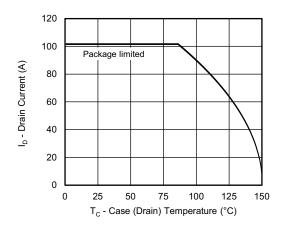
Single Pulse Power, Junction-to-Ambient



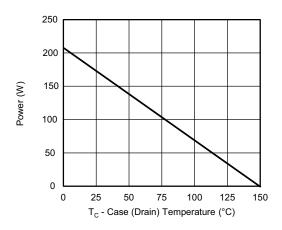
Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



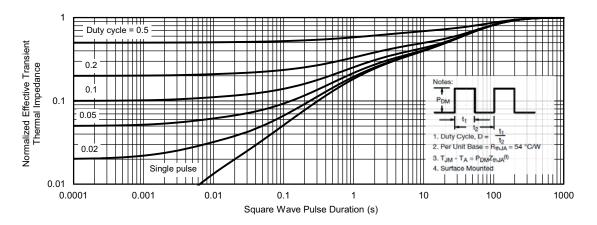
Current Derating a



Power, Junction-to-Case

Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



Normalized Thermal Transient Impedance, Junction-to-Ambient





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